

“Integrated X-ray fluorescence and diffuse visible-to-near-infrared reflectance scanner for standoff elemental and molecular spectroscopic imaging of paints and works on paper”. Delaney JK, Conover DM, Dooley KA, Glinsman L, Janssens K, Loew M, Heritage science **6**, 31 (2018). <http://doi.org/10.1186/S40494-018-0197-Y>